Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/562,437	AHN, BYUNG HWAN	
Examiner	Art Unit	

2834

HANH N. NGUYEN

	SEARCHED				
Class	Subclass	Date	Examiner		
310	61	4/3/2009	HN		
310	62	4/3/2008	HN		
310	58	4/3/2009	HN		
310	64	4/3/2009	HN		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NO (INCLUDING SEARC	OTES H STRATEGY	<b>'</b> )
•	DATE	EXMR